

1200V 15A Trench and Field Stop IGBT

JJT15N120SE

Key performance:

- $V_{\rm CE}$ =1200V
- $I_{\rm C}=15{\rm A}@T_{\rm C}=100{^{\circ}{\rm C}}$
- $V_{\text{CE(sat)}}=1.7\text{V}$

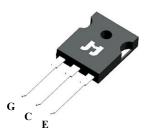
Features:

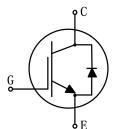
- Trench and field-stop technology
- Low collector to emitter saturation voltage
- Easy parallel switching capability
- Short circuit withstands time 10μs
- High ruggedness performance
- RoHS compliant

Applications:

- Inverter
- Motor driver







Package parameters

Туре	Marking	Package	Packaging Method	
JJT15N120SE	T15120SE	TO-247	Tube	



Maximum ratings

Symbol	Parameter	Values	Unit
V_{CES}	Collector-emitter voltage	1200	V
$V_{ m GES}$	Gate-emitter voltage	±20	V
7	Continuous collector current (T _C =25°C)	30	A
$I_{ m C}$	Continuous collector current (T _C =100°C)	15	A
I_{CM}	Pulsed collector current, t_p limited by T_{vjmax}	60	A
$I_{ m F}$	Diode continuous forward current (T _C =100°C)	15	A
$I_{ m FM}$	Diode maximum current, t_p limited by T_{vjmax}	60	A
$t_{ m sc}$	Short circuit withstand time	10	μs
n	Power dissipation ($T_{\rm C}$ =25°C)		W
P_{tot}	P_{tot} Power dissipation ($T_{\text{C}}=100^{\circ}\text{C}$)		W
$T_{ m vj}$	Operating junction temperature range	-40 to +175	°C
$T_{ m stg}$	Storage temperature range	-55 to +150	°C

Thermal characteristics

C	Parameter		Values		
Symbol			Max.	Unit	
$R_{ m th(j-c)}$	Thermal resistance, junction to case for IGBT	-	0.4	K/W	
$R_{ m th(j-c)}$	Thermal resistance, junction to case for Diode	-	1.2	K/W	
$R_{ m th(j-a)}$	Thermal resistance, junction to ambient		40	K/W	



Electrical characteristics of IGBT $(T_{vj}=25^{\circ}\text{C} \text{ unless otherwise specified})$

Static characteristics

C	D	T-4 1'4'	Values			TI:4
Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
$BV_{\rm CES}$	Collector-emitter breakdown voltage	$V_{\rm GE} = 0 \text{V}, I_{\rm C} = 250 \mu \text{A}$	1200	-	-	V
I_{CES}	Collector-emitter leakage current	$V_{\rm CE} = 1200 \text{V}, V_{\rm GE} = 0 \text{V}$	-	-	250	μΑ
I	Gate leakage current, forward	$V_{\rm GE} = 20 \text{V}, V_{\rm CE} = 0 \text{V}$	-	-	100	nA
$I_{ m GES}$	Gate leakage current, reverse	$V_{\rm GE}$ =-20V, $V_{\rm CE}$ =0V	-	-	-100	nA
$V_{\mathrm{GE(th)}}$	Gate-emitter threshold voltage	$V_{\text{GE}} = V_{\text{CE}}, I_{\text{C}} = 1 \text{mA}$	5.7	6.2	6.5	V
17		$V_{\rm GE}$ =15 V, $I_{\rm C}$ =15A	-	1.7	-	V
V _{CE(sat)}	Collector-emitter saturation voltage	V_{GE} =15V, I_{C} =15A, T_{vj} =175°C	-	2.2	-	V

Dynamic characteristics

Cymph ol	Donom store	Tr. 4 1141	Values			11
Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
C_{ies}	Input capacitance	$V_{\rm CE}$ =30V	1	1250	-	pF
$C_{ m oes}$	Output capacitance	$V_{ m GE}\!\!=\!\!0{ m V}$	-	58	-	pF
$C_{ m res}$	Reverse transfer capacitance	f=1 MHz		13	-	pF
$Q_{ m g}$	Total gate charge	V_{CC} =960V V_{GE} =15V I_C =15A	-	74	-	nC



Switching characteristics

6 1 1	Symbol Parameter	T. 4 114	Values			Unit
Symbol		Test condition	Min.	Тур.	Max.	Unit
$t_{ m d(on)}$	Turn-on delay time		-	22	-	ns
$t_{ m r}$	Rise time		-	34	-	ns
$t_{ m d(off)}$	Turn-off delay time	$V_{\rm CC} = 600 \text{V}$ $V_{\rm GE} = 0/15 \text{V}$	-	140	ı	ns
$t_{ m f}$	Fall time	$I_{\rm C}=15{\rm A}$	-	90	ı	ns
$E_{ m on}$	Turn-on energy	$R_{\rm G}$ =10 Ω Inductive load	-	0.9	1	mJ
$E_{ m off}$	Turn-off energy		-	0.7	-	mJ
$E_{ m ts}$	Total switching energy		-	1.6	1	mJ
$t_{ m d(on)}$	Turn-on delay time		-	22	1	ns
$t_{ m r}$	Rise time		-	38	-	ns
$t_{ m d(off)}$	Turn-off delay time	V_{CC} =600V V_{GE} =0/15V	-	166	-	ns
$t_{ m f}$	Fall time	$I_{\rm C}$ =15A $R_{\rm G}$ =10 Ω Inductive load $T_{\rm vj}$ =175 °C	-	146	-	ns
$E_{ m on}$	Turn-on energy		-	1.1	-	mJ
$E_{ m off}$	Turn-off energy		-	1.0	-	mJ
$E_{ m ts}$	Total switching energy		-	2.1	-	mJ



Electrical characteristics of Diode $(T_{vj}=25^{\circ}\text{C} \text{ unless otherwise specified})$

6 11	D	7D 4 1141	Values			TT .*4
Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
IV.		$I_{\rm F}$ =15A	-	2.3	-	V
$V_{ m F}$	Diode forward voltage	$I_{\rm F}=15{\rm A},\ T_{\rm vj}=175{\rm ^{\circ}C}$	-	1.9	-	V
$t_{ m rr}$	Diode reverse recovery time	V600V	-	223	-	ns
$I_{ m rrm}$	Diode peak reverse recovery current	$V_{\rm R}$ =600V $I_{\rm F}$ =15A	-	8	-	A
$Q_{ m rr}$	Diode reverse recovery charge	$\mathrm{d}i_{\mathrm{F}}/\mathrm{d}t$ =-250A/ μ s	-	718	-	nC
$t_{ m rr}$	Diode reverse recovery time	$V_{ m R}$ =600V $I_{ m F}$ =15A $di_{ m F}$ / dt =-250A/ μ s	-	396	-	ns
$I_{ m rrm}$	Diode peak reverse recovery current		-	11	-	A
$Q_{\rm rr}$	Diode reverse recovery charge	<i>T</i> _{vj} =175℃	-	1700	-	nC



Typical performance characteristics

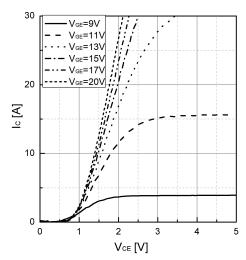


Fig 1. Typical output characteristic (T_{vj} =25°C)

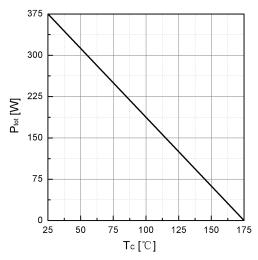


Fig 3. Power dissipation as a function of T_C

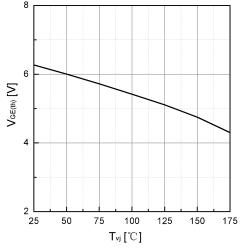


Fig 5. Typical $V_{\text{GE(th)}}$ as a function of T_{vj} ($I_{\text{C}}=1\,\text{mA}$)

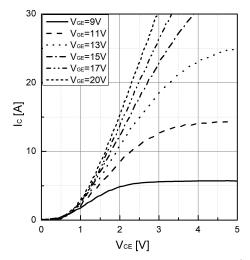


Fig 2. Typical output characteristic(T_{vj} =175°C)

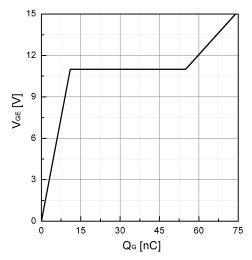


Fig 4. Typical Gate charge

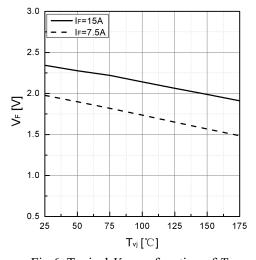


Fig 6. Typical V_F as a function of T_{vj}



Typical performance characteristics

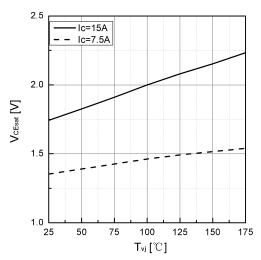


Fig 7. Typical V_{CEsat} as a function of T_{vj}

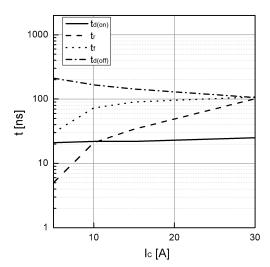


Fig 9. Typical switching time as a function of $I_{\rm C}$

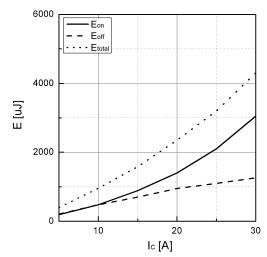


Fig 11. Typical switching energy losses as a function of $I_{\mathbb{C}}$

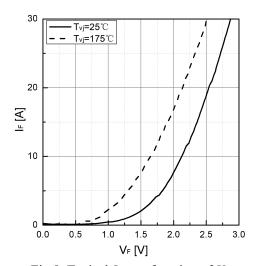


Fig 8. Typical I_F as a function of V_F

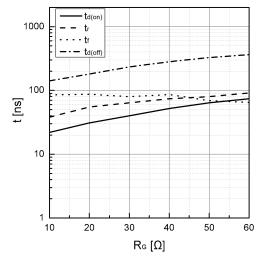


Fig 10. Typical switching times as a function of R_G

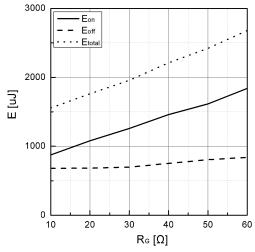


Fig 12. Typical switching energy losses as a function of R_G



Typical performance characteristics

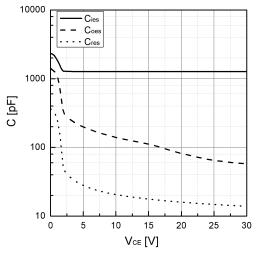


Fig 13. Typical capacitance as a function of $V_{\rm CE}$ (f=1Mhz, $V_{\rm GE}$ =0V)

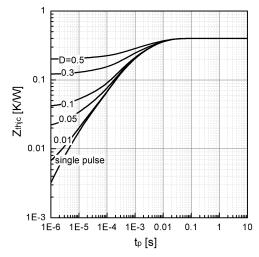
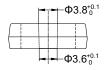


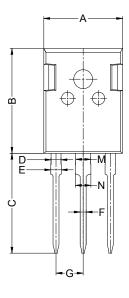
Fig 14. Transient thermal impedance of IGBT

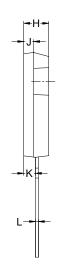


Package dimension

TO-247







			Dime	nsions		
Ref.		Millimeters			Inches	
	Min.	Тур.	Max.	Min.	Тур.	Max.
A	15.50	15.80	16.10	0.610	0.622	0.634
В	20.80	21.00	21.20	0.819	0.827	0.835
С	19.70	20.00	20.30	0.776	0.787	0.799
D	1.80	2.00	2.20	0.071	0.079	0.087
Е	1.90	2.10	2.30	0.075	0.083	0.091
F	1.00	1.20	1.40	0.039	0.047	0.055
G	5.25	-	5.65	0.207	-	0.222
Н	4.80	5.00	5.20	0.189	0.197	0.205
J	1.90	2.00	2.10	0.075	0.079	0.083
K	2.20	2.35	2.50	0.087	0.093	0.098
L	0.41	0.60	0.79	0.016	0.024	0.031
M	2.80	3.00	3.20	0.110	0.118	0.126
N	2.90	3.10	3.30	0.114	0.122	0.130



Revision history

Date	Revision	Changes
2023-12-12	Rev 1.0	Release of the datasheet
2024-03-20	Rev 1.1	Update
2024-05-17	Rev 1.2	Update

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